

Substitute for form 1449/PTO			<b>Complete if Known</b>		
<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  (Use as many sheets as necessary)			Application Number	09/635,850-Conf. #8507	
			Filing Date	August 11, 2000	
			First Named Inventor	Byung J. Kim	
			Art Unit	2621	
			Examiner Name	J. J. Vent	
Sheet	1	of	2	Attorney Docket Number	0465-1915PUS1

U.S. PATENT DOCUMENTS					
Examiner Initials*	Cite No.	Document Number Number-Kind Code <sup>2</sup> (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear
	AA*	US-5,377,051	12-27-1994	Lane et al.	
	AB*	US-5,535,008-A	07-09-1996	Yamagishi et al.	
	AC*	US-2002-0118953	08-29-2002	KIM	
	AD*	US-20030189879	10-09-2003	ISHII et al.	
	AE*	US-20040081435	04-29-2004	Maehashi et al.	
	AF*	US-5,719,982	02-17-1998	Kawamura et al.	
	AG*	US-5,801,781	09-01-1998	Hiroshima et al.	
	AH*	US-5,818,547	10-06-1998	Ozaki et al.	
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	AK*	US-6,021,168	02-01-2000	Huh et al.	
	AL*	US-6,118,486	09-12-2000	Reitmeier	
	AM*	US-6,169,843-B1	01-02-2001	Lenihan et al.	
	AN*	US-6,181,872-B1	01-30-2001	Yamane et al.	
	AO*	US-6,211,800-B1	04-03-2001	Yanagihara et al.	
	AP*	US-6,373,856-B1	04-16-2002	Higashida et al.	
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	AR*	US-6,467,093-B1	10-15-2002	Inoue et al.	
	AS*	US-6,567,409-B1	05-20-2003	Tozaki et al.	

FOREIGN PATENT DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages Or Relevant Figures Appear	†*
		Country Code <sup>3</sup> -Number <sup>4</sup> -Kind Code <sup>5</sup> (if known)				
BA		CN-1221284-A	06-30-1999	Samsung Electronics Co., Ltd.		
BB		JP-06-178288	06-24-1994	Matsushita Electric Ind. Co. Ltd.		
BC		JP-08-140043	05-31-1996	Mitsubishi Electric Corp.		

Examiner Signature		Date Considered	
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\*EXAMINER: initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. \* CITE NO.: Those application(s) which are marked with an single asterisk (\*) next to the Cite No. are not supplied (under 37 CFR 1.98(p)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IPW. \* Applicant's unique citation designation number (optional). \* See Kind Code of USPTO Patent Documents at [www.uspto.gov](http://www.uspto.gov) or MPEP 901.04. \* Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). \* For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. \* Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. \* Applicant is to place a check mark here if English language Translation is attached.

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		Number-Kind Code <sup>2</sup> (if known)			
	AT*	US-6,580,869-B1	06-17-2003	Ando et al.	
	AU*	US-6,618,549-B1	09-09-2003	Kato et al.	
	AV*	US-6,754,273-B1	06-22-2004	Sackstein et al.	
	AW*	US-6,782,189-B2	08-24-2004	Ando et al.	
	AX*	US-6,792,198-B1	09-14-2004	Kim et al.	
	AY*	US-6,865,747-B1	03-08-2005	Mercier	
	AZ*	US-6,901,078-B2	05-31-2005	Morris et al.	
	AA1*	US-7,088,911-B2	08-08-2006	Himeno et al.	

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		Country Code <sup>2</sup> -Number <sup>3</sup> -Kind Code <sup>2</sup> (If Known)				
	BD	JP-11-261963-A	09-24-1999	Sharp Corp.		
	BE	JP-11-045512	02-16-1999	Hitachi Ltd.		
	BF	KR-10-0252108-B1	01-17-2000	Samsung Electronics Co., Ltd.		
	BG	KR-1998-040115	03-22-2005	LG Electronics Inc.		
	BH	KR-10-2000-0026049-A	05-06-2000	LG Electronics Inc.		
	BI	WO-01/20826	03-22-2001	Matsushita Electric Ind. Co. Ltd.		

NON PATENT LITERATURE DOCUMENTS						
Examiner Initials*	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.				T <sup>2</sup>

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<sup>1</sup>Applicant's unique citation designation number (optional). <sup>2</sup>Applicant is to place a check mark here if English language Translation is attached.

Date: July 14, 2008